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| Notice of References Cited | Application/Control No. 10/091,206 | | Applicant(s)/Patent Under Reexamination BANTZ ET AL. | |
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U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|--------------------------|----------------|
| * | A | US-5,204,961 | 04-1993 | Barlow, Douglas C. | 713/201 |
| * | B | US-5,369,706 | 11-1994 | Latka, David S. | 380/262 |
| * | C | US-5,845,068 | 12-1998 | Winiger, Gary W. | 713/200 |
| * | D | US-6,041,410 | 03-2000 | Hsu et al. | 713/186 |
| * | E | US-6,078,888 | 06-2000 | Johnson, Jr., William S. | 705/1 |
| * | F | US-6,081,893 | 06-2000 | Grawrock et al. | 713/183 |
| * | G | US-6,185,307 | 02-2001 | Johnson, Jr., William S. | 380/270 |
| * | H | US-2002/0109580 | 08-2002 | Shreve et al. | 340/5.61 |
| * | I | US-2002/0178364 | 11-2002 | Weiss, Kenneth P. | 713/182 |
| * | J | US-2003/0069848 | 04-2003 | Larson et al. | 705/50 |
| * | K | US-2003/0105964 | 06-2003 | Brainard et al. | 713/178 |
| * | L | US-6,590,981 | 07-2003 | Fruehauf et al. | 380/260 |
| * | M | US-6,748,536 | 06-2004 | Madau, Adrian | 713/193 |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
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NON-PATENT DOCUMENTS

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

| | | | |
|-----------------------------------|---------------------------------------|--|-------------|
| Notice of References Cited | Application/Control No. 10/091,206 | Applicant(s)/Patent Under Reexamination BANTZ ET AL. | |
| | Examiner David G. Cervetti | Art Unit 2136 | Page 2 of 7 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|--------------------|----------------|
| * | A | US-4,914,697 | 04-1990 | Dabbish et al. | 380/28 |
| * | B | US-5,267,312 | 11-1993 | Thompson et al. | 380/237 |
| * | C | US-5,524,051 | 06-1996 | Ryan, John O. | 380/237 |
| * | D | US-6,038,666 | 03-2000 | Hsu et al. | 713/186 |
| * | E | US-6,266,418 | 07-2001 | Carter et al. | 380/257 |
| * | F | US-2002/0027994 | 03-2002 | Katayama et al. | 380/269 |
| * | G | US-2003/0073460 | 04-2003 | van Pelt et al. | 455/556 |
| * | H | US-2003/0142960 | 07-2003 | Yokota et al. | 386/94 |
| * | I | US-6,647,496 | 11-2003 | Tagawa et al. | 713/193 |
| * | J | US-6,668,204 | 12-2003 | Neoh, Chong Lim | 700/94 |
| * | K | US-6,728,585 | 04-2004 | Neoh, Chong Lim | 700/94 |
| * | L | US-6,859,535 | 02-2005 | Tatebayashi et al. | 380/201 |
| * | M | US-6,865,431 | 03-2005 | Hirota et al. | 700/94 |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
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NON-PATENT DOCUMENTS

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

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|-----------------------------------|---------------------------------------|--|--|-------------|
| Notice of References Cited | Application/Control No. 10/091,206 | | Applicant(s)/Patent Under Reexamination BANTZ ET AL. | |
| | Examiner David G. Cervetti | | Art Unit 2136 | Page 3 of 7 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|--------------------|----------------|
| * | A | US-4,440,976 A | 04-1984 | Bocci et al. | 380/277 |
| * | B | US-4,821,097 A | 04-1989 | Robbins, Clyde | 348/485 |
| * | C | US-5,305,384 A | 04-1994 | Ashby et al. | 380/29 |
| * | D | US-5,499,298 A | 03-1996 | Narasimhalu et al. | 705/54 |
| * | E | US-5,787,180 | 07-1998 | Hall et al. | 380/52 |
| * | F | US-6,157,722 A | 12-2000 | Lerner et al. | 380/260 |
| * | G | US-2002/0057795 A1 | 05-2002 | Spurgat et al. | 380/1 |
| * | H | US-2003/0007643 A1 | 01-2003 | Ben-Zur et al. | 380/277 |
| * | I | US-2003/0034877 A1 | 02-2003 | Miller et al. | 340/5.61 |
| * | J | US-6,603,388 B1 | 08-2003 | Perraud et al. | 340/5.61 |
| * | K | US-2004/0076294 A1 | 04-2004 | Shibata et al. | 380/201 |
| * | L | US-6,748,485 B1 | 06-2004 | Yokota et al. | 711/112 |
| * | M | US-6,782,102 | 08-2004 | Blanchard et al. | 380/270 |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
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NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

| | | | | |
|-----------------------------------|---------------------------------------|--|--|-------------|
| Notice of References Cited | Application/Control No. 10/091,206 | | Applicant(s)/Patent Under Reexamination BANTZ ET AL. | |
| | Examiner David G. Cervetti | | Art Unit 2136 | Page 4 of 7 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|---------------------------|----------------|
| * | A | US-4,744,080 A | 05-1988 | Brennand et al. | 380/212 |
| * | B | US-4,903,298 A | 02-1990 | Cline, James D. | 380/270 |
| * | C | US-5,377,270 A | 12-1994 | Koopman et al. | 380/262 |
| * | D | US-6,034,617 A | 03-2000 | Luebke et al. | 340/5.62 |
| * | E | US-6,194,991 B1 | 02-2001 | Barrs et al. | 340/5.72 |
| * | F | US-6,236,727 B1 | 05-2001 | Ciacelli et al. | 380/212 |
| * | G | US-2002/0031139 A1 | 03-2002 | Yoshizawa, Junichi | 370/419 |
| * | H | US-2002/0040255 A1 | 04-2002 | Neoh, Chong Lim | 700/94 |
| * | I | US-2002/0040254 A1 | 04-2002 | Neoh, Chong Lim | 700/94 |
| * | J | US-2002/0147927 A1 | 10-2002 | Tait, John King Frederick | 713/201 |
| * | K | US-2003/0040344 A1 | 02-2003 | Shteyn et al. | 455/573 |
| * | L | US-6,741,659 B1 | 05-2004 | Chan et al. | 375/295 |
| * | M | US-2004/0123321 A1 | 06-2004 | Strierner, Bryan Lester | 725/062 |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
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NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

| | | | | |
|-----------------------------------|---------------------------------------|--|--|-------------|
| Notice of References Cited | Application/Control No. 10/091,206 | | Applicant(s)/Patent Under Reexamination BANTZ ET AL. | |
| | Examiner David G. Cervetti | | Art Unit 2136 | Page 5 of 7 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|---------------------|----------------|
| * | A | US-4,890,321 A | 12-1989 | Seth-Smith et al. | 380/231 |
| * | B | US-5,604,801 A | 02-1997 | Dolan et al. | 713/159 |
| * | C | US-5,903,704 A | 05-1999 | Owashi et al. | 386/95 |
| * | D | US-6,112,103 A | 08-2000 | Puthuff, Steven H. | 455/557 |
| * | E | US-6,134,660 A | 10-2000 | Boneh et al. | 713/193 |
| * | F | US-6,273,359 B1 | 08-2001 | Newman et al. | 242/595 |
| * | G | US-6,307,940 B1 | 10-2001 | Yamamoto et al. | 380/277 |
| * | H | US-6,314,190 B1 | 11-2001 | Zimmermann, Philip | 380/282 |
| * | I | US-6,393,565 B1 | 05-2002 | Lockhart et al. | 713/172 |
| * | J | US-6,510,515 B1 | 01-2003 | Raith, Alex Krister | 713/163 |
| * | K | US-6,510,182 B1 | 01-2003 | Lee et al. | 375/259 |
| * | L | US-2003/0007640 A1 | 01-2003 | Harada et al. | 380/270 |
| * | M | US-6,938,169 B1 | 08-2005 | Caronni et al. | 380/33 |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
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NON-PATENT DOCUMENTS

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| | U | |
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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| | | | | |
|-----------------------------------|---------------------------------------|--|--|-------------|
| Notice of References Cited | Application/Control No. 10/091,206 | | Applicant(s)/Patent Under Reexamination BANTZ ET AL. | |
| | Examiner David G. Cervetti | | Art Unit 2136 | Page 6 of 7 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|--------------------|----------------|
| * | A | US-5,120,939 A | 06-1992 | Claus et al. | 235/382 |
| * | B | US-5,400,403 A | 03-1995 | Fahn et al. | 705/51 |
| * | C | US-5,544,161 A | 08-1996 | Bigham et al. | 370/397 |
| * | D | US-5,598,476 A | 01-1997 | LaBarre et al. | 713/171 |
| * | E | US-5,915,025 A | 06-1999 | Taguchi et al. | 380/44 |
| * | F | US-5,937,065 A | 08-1999 | Simon et al. | 380/262 |
| * | G | US-5,970,149 A | 10-1999 | Johnson, R. Brent | 714/46 |
| * | H | US-6,021,203 A | 02-2000 | Douceur et al. | 380/252 |
| * | I | US-6,236,333 B1 | 05-2001 | King, Joseph David | 340/5.61 |
| * | J | US-6,323,566 B1 | 11-2001 | Meier, Herbert | 307/10.2 |
| * | K | US-6,377,173 B1 | 04-2002 | Desai, Tejas | 340/426.36 |
| * | L | US-6,408,390 B1 | 06-2002 | Saito, Makoto | 713/193 |
| * | M | US-6,438,694 B2 | 08-2002 | Saito, Makoto | 713/189 |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
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NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
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| | | | |
|-----------------------------------|---------------------------------------|--|-------------|
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| | Examiner David G. Cervetti | Art Unit 2136 | Page 7 of 7 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|----------------------------|----------------|
| * | A | US-4,575,621 A | 03-1986 | Dreifus, Henry N. | 235/380 |
| * | B | US-5,933,090 A | 08-1999 | Christenson, Keith A. | 340/825.69 |
| * | C | US-5,952,937 A | 09-1999 | Koopman et al. | 340/825.72 |
| * | D | US-6,035,398 A | 03-2000 | Bjorn, Vance | 713/186 |
| * | E | US-RE36,752 E | 06-2000 | Koopman et al. | 380/262 |
| * | F | US-2001/0038328 A1 | 11-2001 | King et al. | 340/5.64 |
| * | G | US-2002/0010679 A1 | 01-2002 | Felsher, David Paul | 705/51 |
| * | H | US-2002/0040434 A1 | 04-2002 | Elliston et al. | 713/186 |
| * | I | US-2002/0110242 A1 | 08-2002 | Bruwer, Frederick Johannes | 380/255 |
| * | J | US-2003/0093693 A1 | 05-2003 | Blight et al. | 713/201 |
| * | K | US-2003/0149666 A1 | 08-2003 | Davies, Philip Michael | 705/50 |
| * | L | US-6,617,961 B1 | 09-2003 | Janssen et al. | 340/5.8 |
| * | M | US-6,850,252 B1 | 02-2005 | Hoffberg, Steven M. | 715/716 |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
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NON-PATENT DOCUMENTS

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.